

January, 2006

# FPAB50PH60

## **Smart Power Module for Front-End Rectifier**

### **General Description**

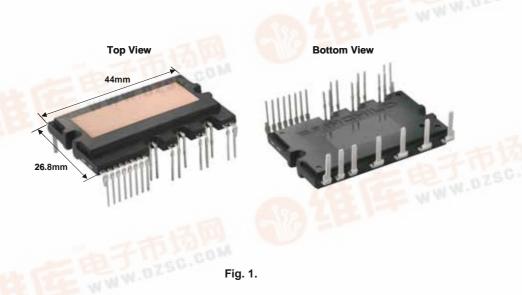
FPAB50PH60 is an advanced smart power module of PFC(Power Factor Correction) that Fairchild has newly developed and designed mainly targeting mid-power application especially for an air conditioners. It combines optimized circuit protection and drive IC matched to high frequency switching IGBTs. System reliability is futher enhanced by the integrated under-voltage lock-out and over-current protection function.

### **Features**

- Low thermal resistance due to AIN-DBC substrate
- 600V-50A 2-phase IGBT PWM semi-converter including a drive IC for IGBT gate driving and protection
- Typical switching frequency of 20kHz
- Isolation rating of 2500Vrms/min.

## **Applications**

• AC 180V ~ 264V single-phase front-end rectifier





## **Integrated Power Functions**

• PFC converter for single-phase AC/DC power conversion (Please refer to Fig. 3)

# **Integrated Drive, Protection and System Control Functions**

- For IGBTs: Gate drive circuit, Overcurrent circuit protection (OC), Control supply circuit under-voltage (UV) protection
- Fault signaling: Corresponding to a UV fault
   Input interface: 5V CMOS/LSTTL compatible, Schmitt trigger input

# **Pin Configuration**

## **Top View**

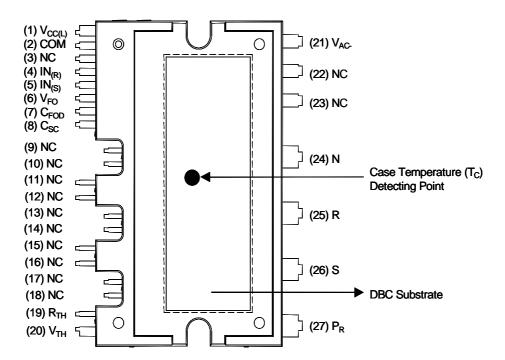
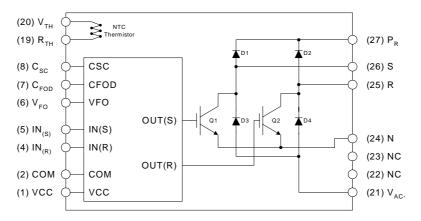


Fig. 2.

Pin Descripti	ons
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Pin Number	Pin Name	Pin Description	
1	V <sub>CC</sub>	Common Bias Voltage for IC and IGBTs Driving	
2	COM	Common Supply Ground	
4	IN <sub>(R)</sub>	Signal Input for Low-side R-phase IGBT	
5	IN <sub>(S)</sub>	Signal Input for Low-side S-phase IGBT	
6	V <sub>FO</sub>	Fault Output	
7	C <sub>FOD</sub>	Capacitor for Fault Output Duration Time Selection	
8	C <sub>SC</sub>	Capacitor (Low-pass Filter) for Over Current Detection	
19	R <sub>(TH)</sub>	NTC Thermistor terminal	
20	V <sub>(TH)</sub>	NTC Thermistor terminal	
21	V <sub>AC-</sub>	Negative Terminal of DC-Link (DIODE) for Sensing	
24	N	Negative Rail of DC-Link (IGBT)	
25	R	Output for R Phase	
26	S	Output for S Phase	
27	$P_{R}$	Positive Rail of DC-Link	
3, 9~18, 22~23	NC	No Connection	

# **Internal Equivalent Circuit and Input/Output Pins**



Note:
1) Converter is composed of two IGBTs including four diodes and one IC which has gate driving and protection functions.

Fig. 3.

# **Absolute Maximum Ratings** ( $T_J = 25$ °C, Unless Otherwise Specified)

## **Converter Part**

Item	Symbol	Condition	Rating	Unit
Supply Voltage	V <sub>i</sub>	Applied between R-S	264	$V_{RMS}$
Supply Voltage (Surge)	V <sub>i(Surge)</sub>	Applied between R-S	500	V
Output Voltage	V <sub>PN</sub>	Applied between P- N	450	V
Output Voltage (Surge)	V <sub>PN(Surge)</sub>	Applied between P- N	500	V
Collector-emitter Voltage	V <sub>CES</sub>		600	V
Input Current (100% Load)	I <sub>i</sub>	T <sub>C</sub> < 95°C, V <sub>i</sub> =220V, V <sub>PN</sub> = 390V, V <sub>PWM</sub> =20kHz	30	Α
Input Current (125% Load)	I <sub>i(125%)</sub>	T <sub>C</sub> < 95°C, V <sub>i</sub> =220V, V <sub>PN</sub> = 390V, V <sub>PWM</sub> =20kHz, 1min Non-repetitive	37.5	А
Collector Dissipation	P <sub>C</sub>	T <sub>C</sub> = 25°C per One IGBT	143	W
Operating Junction Temperature	TJ	(Note 1)	-20 ~ 125	°C

## **Control Part**

Item	Symbol	Condition	Rating	Unit
Control Supply Voltage	$V_{CC}$	Applied between V <sub>CC</sub> - COM	20	V
Input Signal Voltage	V <sub>IN</sub>	Applied between IN - COM	-0.3~5.5	V
Fault Output Supply Voltage	$V_{FO}$	Applied between V <sub>FO</sub> - COM	-0.3~V <sub>CC</sub> +0.3	V
Fault Output Current	I <sub>FO</sub>	Sink Current at V <sub>FO</sub> Pin	5	mA
Current Sensing Input Voltage	$V_{SC}$	Applied between C <sub>SC</sub> - COM	-0.3~V <sub>CC</sub> +0.3	V

## **Total System**

Item	Symbol	Condition	Rating	Unit
Module Case Operation Temperature	T <sub>C</sub>		-20 ~ 100	°C
Storage Temperature	T <sub>STG</sub>		-40 ~ 125	°C
Isolation Voltage	V <sub>ISO</sub>	60Hz, Sinusoidal, AC 1 minute, Connection Pins to DBC	2500	V <sub>rms</sub>

## **Thermal Resistance**

Item	Symbol	Condition	Min.	Тур.	Max.	Unit
Junction to Case Thermal	$R_{\theta(j-c)Q}$	IGBT	-	-	0.7	°C/W
Resistance	$R_{\theta(j-c)HD}$	High-side diode	-	-	1.5	°C/W
(Referenced to PKG center)	$R_{\theta(j-c)LD}$	Low-side diode	-	-	0.85	°C/W

#### Note:

2. For the measurement point of case temperature(T<sub>C</sub>), please refer to Fig. 2.

Note 1. The maximum junction temperature rating of the power chips integrated within the SPM is 150 °C(@T<sub>C</sub>  $\leq$  100°C). However, to insure safe operation of the SPM, the average junction temperature should be limited to T<sub>J(ave)</sub>  $\leq$  125°C (@T<sub>C</sub>  $\leq$  100°C)

# **Electrical Characteristics** (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

# **Converter Part**

Item	Symbol	Condition	Min.	Тур.	Max.	Unit
IGBT saturation voltage	V <sub>CE(sat)</sub>	V <sub>CC</sub> =15V, V <sub>IN</sub> = 5V; I <sub>C</sub> =50A	-	2.8	3.2	V
High-side diode voltage	$V_{FH}$	I <sub>C</sub> = 50A	-	2.1	2.7	V
Low-side diode voltage	$V_{FL}$	I <sub>C</sub> = 50A	-	1.3	1.7	V
Switching Times	t <sub>ON</sub>	V <sub>PN</sub> = 400V, V <sub>CC</sub> = 15V, I <sub>C</sub> =30A	-	550	-	ns
	t <sub>C(ON)</sub>	$V_{IN} = 0V \leftrightarrow 5V$ , Inductive Load	-	200	-	ns
	t <sub>OFF</sub>	(Note 3)	-	430	-	ns
	t <sub>C(OFF)</sub>	(11010 0)	-	180	-	ns
	t <sub>rr</sub>		-	60	-	ns
	I <sub>rr</sub>		-	6	-	Α
Collector - emitter Leakage Current	I <sub>CES</sub>	V <sub>CE</sub> = V <sub>CES</sub>	-	-	250	μА

### **Control Part**

Item	Symbol	Condition	Min.	Тур.	Max.	Unit
Quiescent $V_{CC}$ Supply Current	I <sub>QCCL</sub>	$V_{CC} = 15V$ , $IN = 0V$ $V_{CC} - COM$	-	-	26	mA
Fault Output Voltage	$V_{FOH}$	$V_{SC}$ = 0V, $V_{FO}$ Circuit: 4.7k $\Omega$ to 5V Pull-up	4.5	-	-	V
	V <sub>FOL</sub>	$V_{SC}$ = 1V, $V_{FO}$ Circuit: 4.7k $\Omega$ to 5V Pull-up	-	-	0.8	V
Over Current Trip Level	V <sub>OC(ref)</sub>	V <sub>CC</sub> = 15V	0.45	0.5	0.55	V
Supply Circuit Under-	UV <sub>CCD</sub>	Detection Level	10.7	11.9	13.0	V
Voltage Protection	UV <sub>CCR</sub>	Reset Level	11.2	12.4	13.2	V
Fault-out Pulse Width	t <sub>FOD</sub>	C <sub>FOD</sub> = 33nF (Note 4)	1.4	1.8	2.0	ms
ON Threshold Voltage	V <sub>IN(ON)</sub>	Applied between IN - COM	3.0	-	-	V
OFF Threshold Voltage	V <sub>IN(OFF)</sub>		-	-	0.8	V
Resistance of Thermistor	R <sub>TH</sub>	@ T <sub>C</sub> = 25°C (Note Fig. 9)	-	50	-	kΩ
		@ T <sub>C</sub> = 80°C (Note Fig. 9)	-	5.76	-	kΩ

Note
 t<sub>ON</sub> and t<sub>OFF</sub> include the propagation delay time of the internal drive IC. t<sub>C(ON)</sub> and t<sub>C(OFF)</sub> are the switching time of IGBT itself under the given gate driving condition internally. For the detailed information, please see Fig. 4

Note
4. The fault-out pulse width  $t_{FOD}$  depends on the capacitance value of  $C_{FOD}$  according to the following approximate equation :  $C_{FOD} = 18.3 \times 10^{-6} \times t_{FOD}[F]$ 

# **Electrical Characteristics**

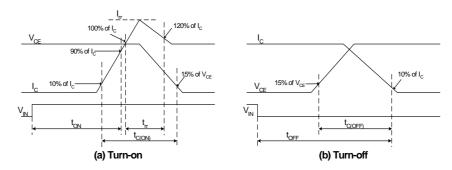


Fig. 4. Switching Time Definition

# **Mechanical Characteristics and Ratings**

Item		Condition		Limits		Units
item	'	Condition	Min.	Тур.	Max.	Units
Mounting Torque	Mounting Screw: - M3	Recommended 0.62N•m	0.51	0.62	0.72	N•m
Device Flatness	Note Fig. 5		0	-	+120	μm
Weight			-	15.00	-	g

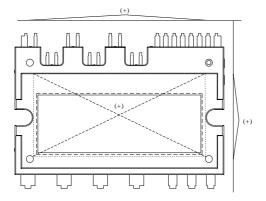
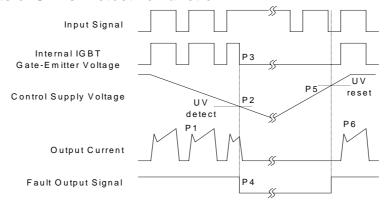


Fig. 5. Flatness Measurement Position

## **Time Charts of SPMs Protective Function**

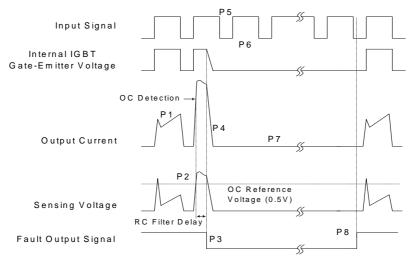


P1: Normal operation - IGBT ON and conducting current

P2 : Under voltage detection P3 : IGBT gate interrupt P4 : Fault signal generation P5 : Under voltage reset

P6: Normal operation - IGBT ON and conducting current

Fig. 6. Under-Voltage Protection



P1: Normal operation - IGBT ON and conducting current

P2 : Over current detection

P3: IGBT gate interrupt / Fault signal generation

P4: IGBT is slowly turned off

P5 : IGBT OFF signal

P6: IGBT ON signal - but IGBT cannot be turned on during the fault Output activation

P7 : IGBT OFF state

P8 : Fault Output reset and normal operation start

Fig. 7. Over Current Protection

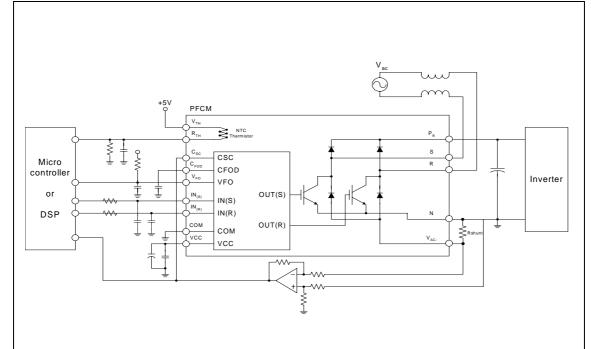


Fig. 8. Application Example
R-T Graph

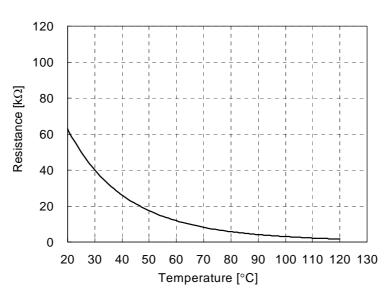
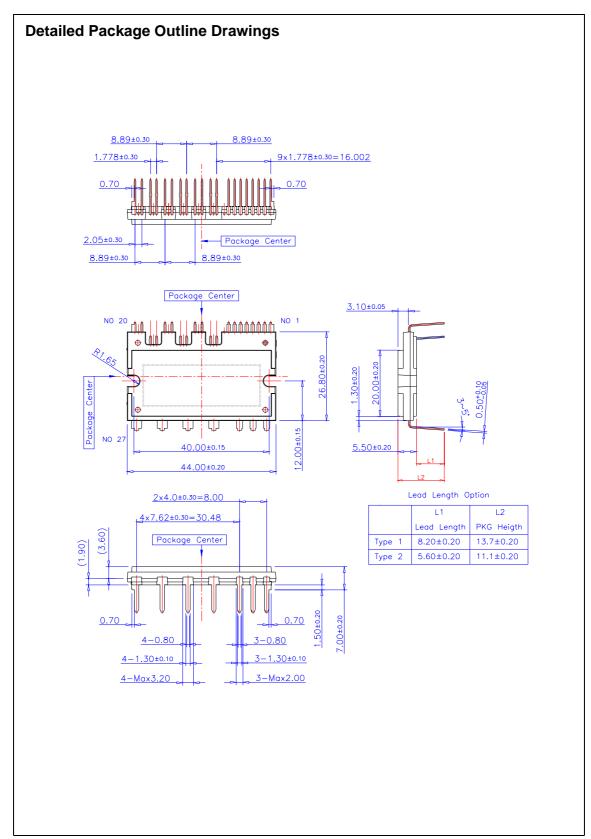
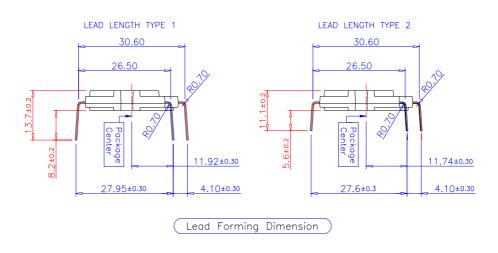
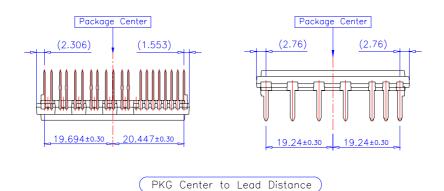


Fig. 9. R-T Curve of the Built-in Thermistor

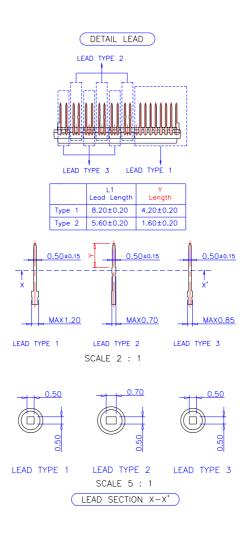


# **Detailed Package Outline Drawings**





# **Detailed Package Outline Drawings**



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